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LIST OF REFERENCES CITED BY APPLICANT					APPLICANT	•	; · •		
		(Use several sheets if i	necessary)		Peyne, et al.				
					FILING DATE Currently herewith: 12/0	3/2001	GROUP To be assi	65	
U.S. PATENT DOCUMENTS									
*EXAMINER		DOCUMENT NUMBER	DATE	S. PATENT DOCON	NAME	CLASS	SUBCLASS		
INITIAL		DOCOMENT NOMBER	DATE		NAME	CLASS	SUBCLASS	IF APPE	G DATE ROPRIATE
pul	AA	5,209,858	05/1993	Heinshon et al.		252	1	82/6	6/199
Jane	AB	5,554,320	09/1996	Yianakopoulos		252	389.23	O9/J3	3/1994
Ren	AC	5,560,857	10/1996	Sakon et al.	510	175	10/11	/1994	
Jeur_	AD	5,739,579	04/1998	Chiang et al.		257	635	લ્સી 16	11994
per	ΑE	5,817,572	10/1998	Chiang et al.		438	624	10/18	11996
Jun2	AF	5,877,075	03/1999	Dai et al.		438	597	10/14	11999
leliz	AG	5,891,799	04/1999	Tsui		438	624	08/1	8/199
0					-				
		·		,					
			FORE	IGN PATENT DOCU	JMENTS		L		
		DOCUMENT NUMBER	DATE		CLASS	SUBCLASS	TRANSLATION		
								· YES	NO
RIN	АН	0 253 675 A1	01/1988	EPO					
Jun 1	Al	EP 0 773 480 A1	05/1997	EPO					
gen !	AJ	EP 0 875 926 A1	11/1998	EPO					
gue !	AK	WO 99/60083	11/1999	PCT					
0									
		OTHER REI	ERENCES (Incl	luding Author, Title,	, Date, Pertinent Pages, Etc	c.)			
EVAMINED .									
EXAMINER (1000). Maldonsolo DATE CONSIDERED 10/19/2008									

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.